Power MOSFET 20 V, 5.8 A/4.6 A Dual N-Channel, DFN6 3x3 mm Package Features

- Exposed Drain Package
- Excellent Thermal Resistance for Superior Heat Dissipation
- Low Threshold Levels
- Low Profile (< 1 mm) Allows It to Fit Easily into Extremely Thin Environments
- This is a Pb-Free Device

Applications

- DC-DC Converters (Buck and Boost Circuits)
- Power Supplies
- Hard Disk Drives

MOSFET I MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Param	Symbol	Value	Unit		
Drain-to-Source Voltage			V _{DSS}	20	V
Gate-to-Source Voltag	е		V _{GS}	±20	V
Continuous Drain	Steady	T _A = 25°C	I _D	4.3	А
Current (Note 1)	State	T _A = 85°C		3.0	
	t ≤ 5.0 s	T _A = 25°C		5.8	
Power Dissipation (Note 1)			P _D	1.74	W
Pulsed Drain Current t ≤10 μs			I _{DM}	17.2	А
Operating Junction and Storage Temperature			T _J , T _{STG}	-55 to 150	°C
Source Current (Body Diode)			۱ _S	1.6	Α
Lead Temperature for S (1/8" from case for 10 s		urposes	ΤL	260	°C

MOSFET II MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Param	Symbol	Value	Unit		
Drain-to-Source Voltag	V _{DSS}	20	V		
Gate-to-Source Voltag	е		V _{GS}	±12	V
Continuous Drain	Steady	T _A = 25°C	I _D	3.6	А
Current (Note 1)	State	T _A = 85°C		2.5	
	t ≤ 5.0 s	T _A = 25°C		4.6	
Power Dissipation (Note 1)	Steady State	$T_A = 25^{\circ}C$	P _D	1.74	W
Pulsed Drain Current t ≤10 μs			I _{DM}	13.8	А
Operating Junction and Storage Temperature			T _J , T _{STG}	-55 to 150	°C
Source Current (Body Diode)			ا _S	1.7	А
Lead Temperature for S (1/8" from case for 10 s		urposes	ΤL	260	°C

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

- 1. Surface Mounted on FR4 Board using 1 in sq pad size (Cu area = 1.127 in sq [1 oz] including traces)
- Surface Mounted on FR4 Board using the minimum recommended pad size of 30 mm², 1 oz. Cu



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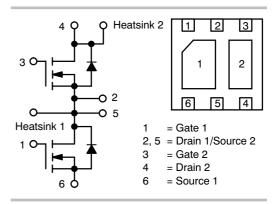
http://onsemi.com

MOSFET I

V _{(BR)DSS}	R _{DS(on)} MAX	I _D MAX
20 V	60 mΩ @ 4.5 V	5.8 A

MOSFET II

V _{(BR)DSS}	R _{DS(on)} MAX	I _D MAX
20 V	90 mΩ @ 4.5 V	4.6 A



DIAGRAMS DFN6 CASE 506AG $1 \begin{bmatrix} \circ & 3502 \\ AYWW \\ \bullet \end{bmatrix}$ 3502 = Specific Device Code A = Assembly Location Y = Year WW = Work Week $\bullet = Pb-Free Package$

MARKING

ORDERING INFORMATION

Device	Package	Shipping [†]
NTLGD3502NT1G	DFN6 (Pb-free)	3000/Tape & Reel
NTLGD3502NT2G	DFN6 (Pb-free)	3000/Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

THERMAL RESISTANCE RATINGS

Parameter	Symbol	Max	Unit
Junction-to-Ambient – Steady State (Note 1)	$R_{ heta JA}$	72	°C/W
Junction-to-Ambient – t \leq 5 s (Note 1)	$R_{ hetaJA}$	40	
Junction-to-Ambient – Steady State min Pad (Note 2)	$R_{ heta JA}$	110	
Junction-to-Ambient – Pulsed (25% duty cycle) min Pad (Note 2)	$R_{ hetaJA}$	60	

MOSFET I ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise noted)

Parameter	Symbol	Test Conditio	ons	Min	Тур	Max	Unit
Off Characteristics	-	-			-	-	-
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	V_{GS} = 0 V, I _D = 250 μ A		20			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /T _J	I _D = 250 μA, ref to	o 25°C		10		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	V_{GS} = 0 V, V_{DS} = 16 V	$T_J = 25^{\circ}C$			1.0	μΑ
			T _J = 125°C			10	
Gate-to-Source Leakage Current	I _{GSS}	V _{DS} = 0 V, V _{GS} =	±20 V			±100	nA
On Characteristics (Note 3)		•					
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_D = 2$	250 μA	1.0	1.7	2.0	V
Negative Threshold Temperature Coefficient	V _{GS(TH)} /T _J				-4.4		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 4.5 V, I _D =	= 4.3 A		50	60	mΩ
Forward Transconductance	9 _{FS}	V _{DS} = 10 V, I _D =	4.0 A		5.9		S
Charges, Capacitances & Gate Resi	stance	•					
Input Capacitance	C _{ISS}	V _{GS} = 0 V, f = 1 MHz, V _{DS} = 10 V			250	480	pF
Output Capacitance	C _{OSS}				138	200	-
Reverse Transfer Capacitance	C _{RSS}				52	90	
Total Gate Charge	Q _{G(TOT)}	V _{GS} = 4.5 V, V _{DS} = 10 V; I _D = 4.3 A (Note 3)			2.9	4.0	nC
Gate-to-Source Charge	Q _{GS}				1.0		-
Gate-to-Drain Charge	Q _{GD}				1.1		
Gate Resistance	R _G				1.5		Ω
Switching Characteristics, V _{GS} = 4.5	V (Note 4)	•					
Turn-On Delay Time	t _{d(ON)}	V_{GS} = 4.5 V, V_{DD}			7.0	12	ns
Rise Time	t _r	I _D = 4.3 A, R _G =	10 Ω		17.5	25	1
Turn-Off Delay Time	t _{d(OFF)}				8.6	15	1
Fall Time	t _f				3.3	5.0	1
Drain-Source Diode Characteristics	-					-	-
Forward Diode Voltage	V _{SD}	V_{GS} = 0 V, I_{S} = 1.6 A	$T_J = 25^{\circ}C$		0.78	1.2	V
			T _J = 125°C		0.63		1
Reverse Recovery Time	t _{RR}	$V_{GS} = 0 V, d_{ISD}/d_t =$	100 A/μs,		16.7		ns
Charge Time	t _a	I _S = 1.0 A			8.2		1
Discharge Time	t _b						1

Reverse Recovery Charge

 $\mathsf{Q}_{\mathsf{R}\mathsf{R}}$

7.0

nC

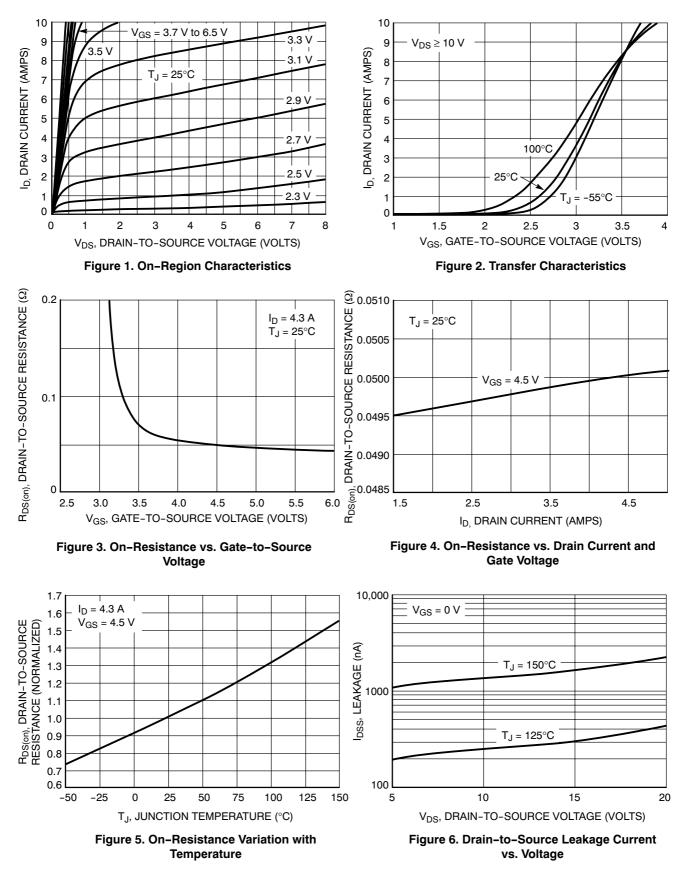
MOSFET II ELECTRICAL CHARACTERISTICS (T_J = 25° C unless otherwise noted)

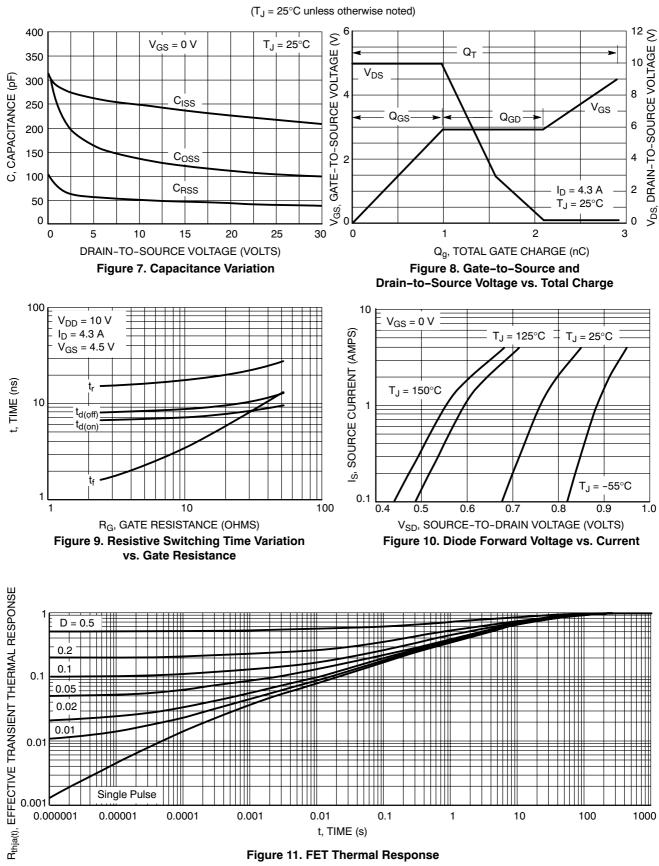
Parameter	Symbol	Test Condition	ons	Min	Тур	Max	Unit
Off Characteristics							
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	V_{GS} = 0 V, I _D = 250 μ A		20			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /T _J	I _D = 250 μA, ref t	o 25°C		22		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	V _{GS} = 0 V, V _{DS} = 16 V	T _J = 25°C T _J = 125°C			1 10	μΑ
Gate-to-Source Leakage Current	I _{GSS}	V _{DS} = 0 V, V _{GS} =	±12 V			±100	nA
On Characteristics (Note 5)						1	
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_D =$	250 μA	0.6		2.0	V
Negative Threshold Temperature Coefficient	V _{GS(TH)} /T _J				-2.8		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 4.5 V, I _D =	= 3.4 A		70	90	mΩ
		V _{GS} = 2.5 V, I _D =	= 1.7 A		95	120	
Forward Transconductance	9 _{FS}	V _{DS} = 10 V, I _D =	= 3.4 A		6.7		S
Charges, Capacitances & Gate Resi	stance						
Input Capacitance	C _{ISS}	V_{GS} = 0 V, f = 1 MHz, V_{DS} = 10 V			144	275	pF
Output Capacitance	C _{OSS}				67	125	
Reverse Transfer Capacitance	C _{RSS}				22	40	
Total Gate Charge	Q _{G(TOT)}	V _{GS} = 4.5 V, V _{DS} = 10	V; I _D = 3.4 A		2.1	5.0	nC
Threshold Gate Charge	Q _{G(TH)}				0.11		
Gate-to-Source Charge	Q _{GS}				0.42		
Gate-to-Drain Charge	Q _{GD}	1 1			0.7		
Switching Characteristics, V _{GS} = 4.5	V (Note 6)	•			•		
Turn-On Delay Time	t _{d(ON)}	V _{GS} = 4.5 V, V _{DD}	= 16 V,		4.8	10	ns
Rise Time	t _r	I _D = 3.4 A, R _G =	10 Ω		13.6	25	
Turn-Off Delay Time	t _{d(OFF)}				9.0	20	
Fall Time	t _f				1.9	5.0	
Drain-Source Diode Characteristics	;	•			•		
Forward Diode Voltage	V _{SD}	V_{GS} = 0 V, I_{S} = 1.7 A	$T_J = 25^{\circ}C$		0.8	1.15	V
			T _J = 150°C		0.63		1
Reverse Recovery Time	t _{RR}	$V_{GS} = 0 V, d_{ISD}/d_t =$	100 A/μs,		12		ns
Charge Time	ta	I _S = 1.0 A			8.0		1
Discharge Time	t _b				4.0		1
Reverse Recovery Charge	Q _{RR}				5.0		nC

5. Pulse Test: pulse width \leq 300 µs, duty cycle \leq 2% 6. Switching characteristics are independent of operating junction temperatures

TYPICAL MOSFET I N-CHANNEL PERFORMANCE CURVES

(T_J = 25° C unless otherwise noted)

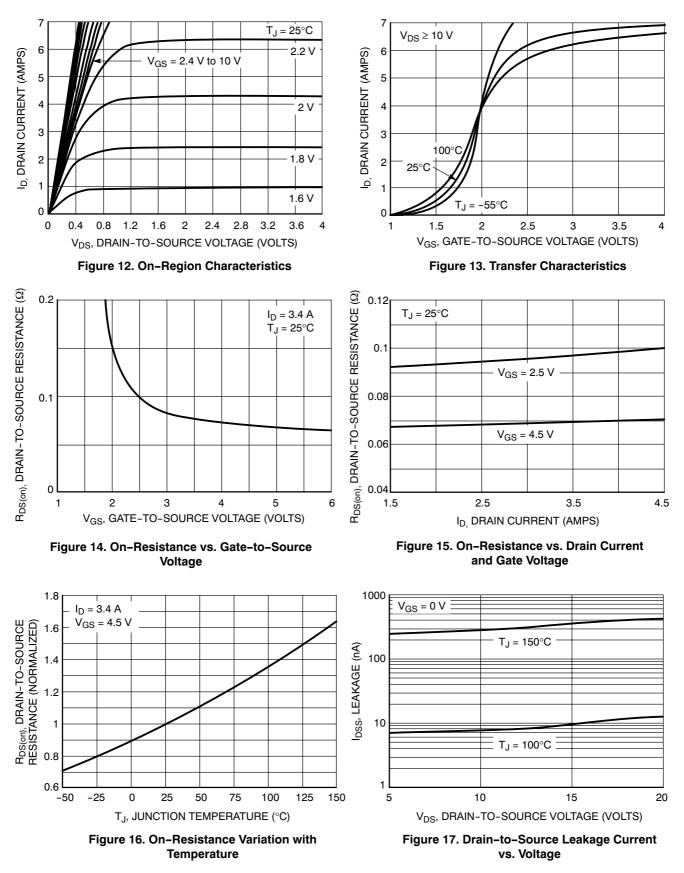


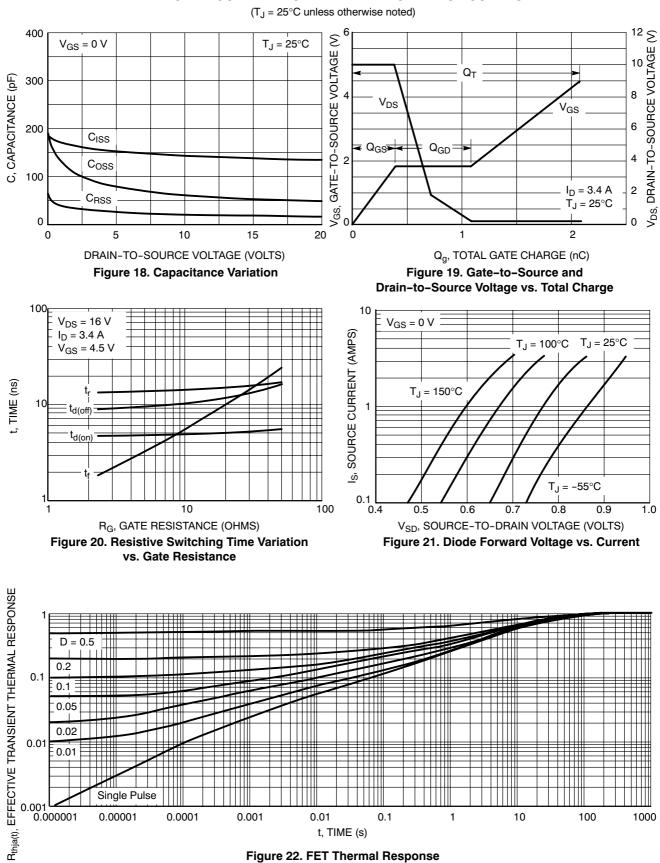


TYPICAL MOSFET I N-CHANNEL PERFORMANCE CURVES

TYPICAL MOSFET II N-CHANNEL PERFORMANCE CURVES

(T_J = 25°C unless otherwise noted)

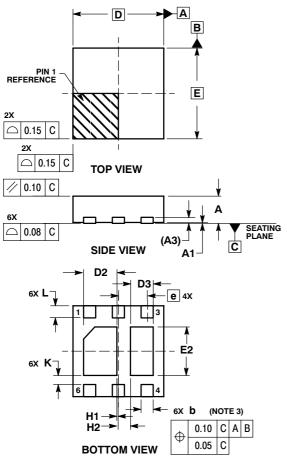




TYPICAL MOSFET II N-CHANNEL PERFORMANCE CURVES

PACKAGE DIMENSIONS

DFN6 3*3 MM, 0.95 PITCH CASE 506AG-01 ISSUE O

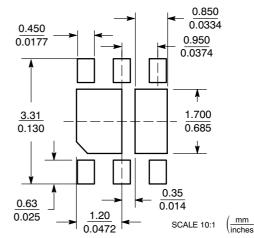


NOTES

- DIMENSIONS AND TOLERANCING PER ASME Y14.5M, 1994.
 CONTROLLING DIMENSION: MILLIMETERS.
- CONTROLLING DIMENSION: MILLIMETERS.
 DIMESNION b APPLIES TO PLATED TERMINAL AND IS MEASURED BETWEEN 0.25 AND 0.30
- AND IS MEASURED BETWEEN 0.25 AND 0.30 MM FROM TERMINAL. 4. COPLANARITY APPLIES TO THE EXPOSED PAD AS WELL AS THE TERMINALS.

	MILLIMETERS			
DIM	MIN	NOM	MAX	
Α	0.80	0.90	1.00	
A1	0.00	0.03	0.05	
A3	0	.20 REF		
b	0.35	0.40	0.45	
D	3	.00 BSC	;	
D2	1.00	1.10	1.20	
D3	0.65	0.75	0.85	
Е	3.00 BSC			
E2	1.50	1.60	1.70	
е	0	.95 BSC	;	
К	0.21			
L	0.30	0.40	0.50	
H1	0.05 REF			
H2	0	.40 REF		

SOLDERING FOOTPRINT*



*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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